

<b>Notice of References Cited</b>	Application/Control No. 10/779,524	Applicant(s)/Patent Under Reexamination YUN ET AL.	
	Examiner Yewebdar T. Tadesse	Art Unit 1734	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,579,139	06-2003	Mishima et al.	445/24
	B	US-6,857,925	02-2005	Kawamura et al.	445/24
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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